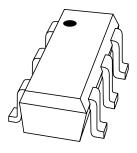
DISCRETE SEMICONDUCTORS

DATA SHEET



BAT74SSchottky barrier double diode

Product data sheet Supersedes data of 1998 Jul 10 2003 Apr 11



Schottky barrier double diode

BAT74S

FEATURES

- Low forward voltage
- · Guard ring protected
- · Small SMD package.

APPLICATIONS

- Ultra high-speed switching
- · Voltage clamping
- · Protection circuits
- · Blocking diodes.

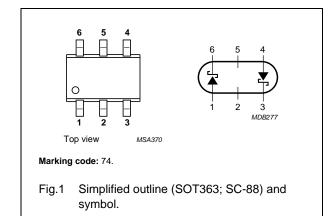
DESCRIPTION

Planar Schottky barrier double diode with an integrated guard ring for stress protection.

Two separate dies are encapsulated in a SOT363 (SC-88) small SMD plastic package.

PINNING

PIN	DESCRIPTION	
1	anode 1	
2	not connected	
3	cathode 2	
4	anode 2	
5	not connected	
6	cathode 1	



LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per diode		•		•	
V_R	continuous reverse voltage		_	30	V
I _F	continuous forward current		-	200	mA
I _{FRM}	repetitive peak forward current	$t_p \leq 1 \text{ s; } \delta \leq 0.5$	-	300	mA
I _{FSM}	non-repetitive peak forward current	$t_p < 10 \text{ ms}$		600	mA
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C; see Fig.2	-	240	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	125	°C
T _{amb}	operating ambient temperature		-65	+125	°C
Double die	ode operation				
V_R	continuous reverse voltage		-	30	V
V_R	continuous reverse voltage	series connection	_	60	V
I _F	continuous forward current		-	110 ⁽¹⁾	mA
I _{FRM}	repetitive peak forward current	$t_p \le 1 \text{ s}; \ \delta \le 0.5$	-	200	mA

Note

1. If both diodes are in forward operation at the same moment, total device current is max. 110 mA. If one diode is in reverse and the other in forward operation at the same moment, total device current is max. 200 mA.

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Schottky barrier double diode

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ELECTRICAL CHARACTERISTICS

 T_{amb} = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT
Per diode				
V _F	forward voltage	see Fig.3		
		$I_F = 0.1 \text{ mA}$	240	mV
		$I_F = 1 \text{ mA}$	320	mV
		I _F = 10 mA	400	mV
		$I_F = 30 \text{ mA}$	500	mV
		I _F = 100 mA	800	mV
I _R	reverse current	V _R = 25 V; note 1; see Fig.4	2	μА
t _{rr}	reverse recovery time	when switched from I_F = 10 mA to I_R = 10 mA; R_L = 100 Ω ; measured at I_R = 1 mA	5	ns
C _d	diode capacitance	f = 1 MHz; V _R = 1 V; see Fig.5	10	pF

Note

1. Pulsed test: t_p = 300 μ s; δ = 0.02.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	note 1	416	K/W

Note

1. Refer to SOT363 standard mounting conditions.

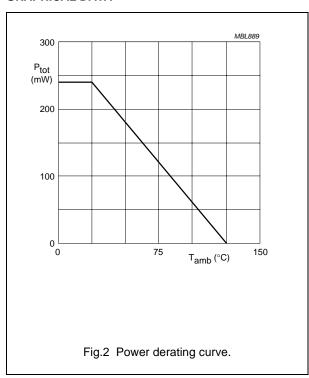
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Schottky barrier double diode

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GRAPHICAL DATA



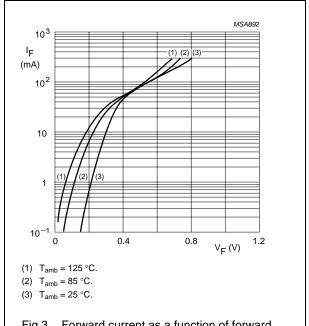
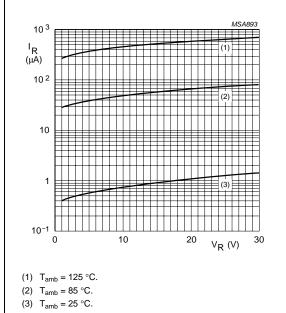
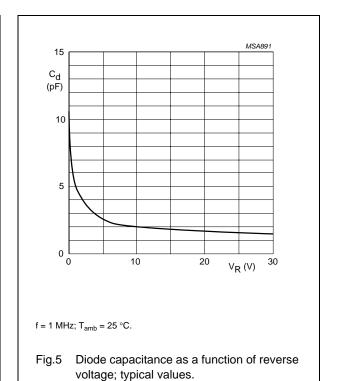


Fig.3 Forward current as a function of forward voltage; typical values.



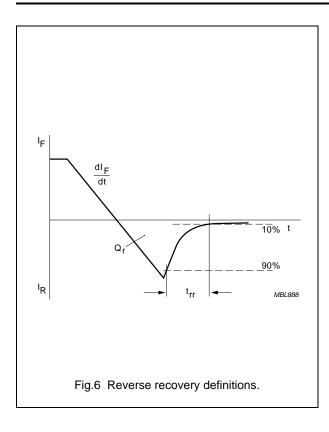
Reverse current as a function of reverse voltage; typical values.



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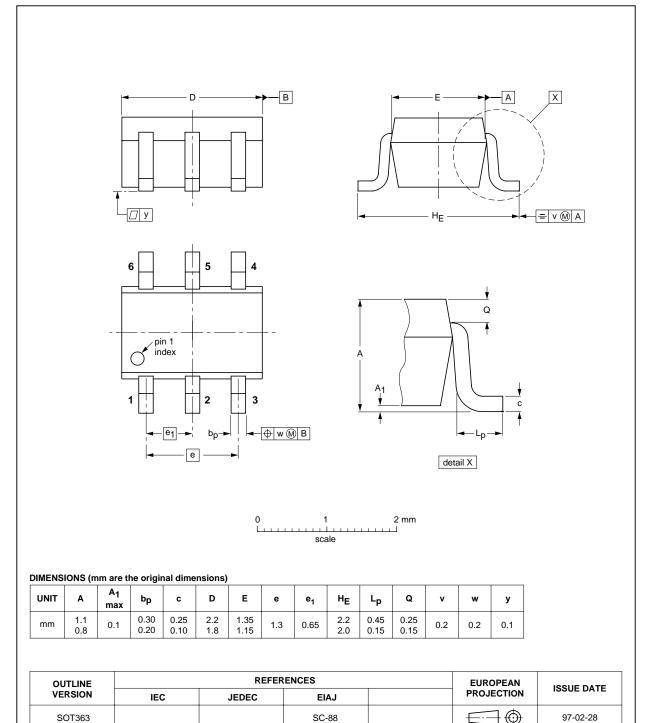
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PACKAGE OUTLINE

Plastic surface mounted package; 6 leads

SOT363



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Schottky barrier double diode

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DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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Printed in The Netherlands 613514/04/pp8 Date of release: 2003 Apr 11 Document order number: 9397 750 11161

